

# TrenchMOS™ transistor

## Logic level FET

BUK9518-55

**GENERAL DESCRIPTION**

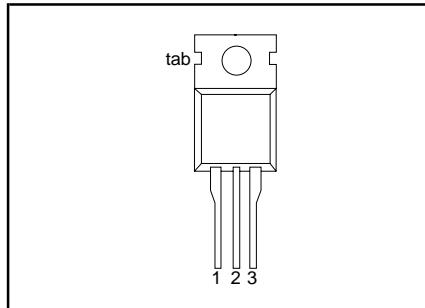
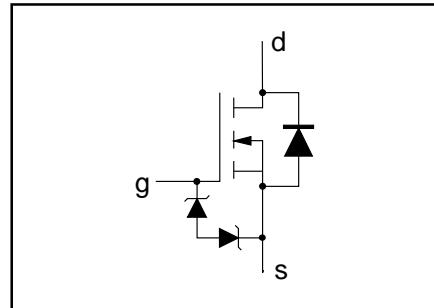
N-channel enhancement mode logic level field-effect power transistor in a plastic envelope using 'trench' technology. The device features very low on-state resistance and has integral zener diodes giving ESD protection up to 2kV. It is intended for use in automotive and general purpose switching applications.

**QUICK REFERENCE DATA**

SYMBOL	PARAMETER	MAX.	UNIT
$V_{DS}$	Drain-source voltage	55	V
$I_D$	Drain current (DC)	57	A
$P_{tot}$	Total power dissipation	125	W
$T_j$	Junction temperature	175	°C
$R_{DS(ON)}$	Drain-source on-state resistance $V_{GS} = 5$ V	18	$m\Omega$

**PINNING - TO220AB**

PIN	DESCRIPTION
1	gate
2	drain
3	source
tab	drain

**PIN CONFIGURATION****SYMBOL****LIMITING VALUES**

Limiting values in accordance with the Absolute Maximum System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_{DS}$	Drain-source voltage	-	-	55	V
$V_{DGR}$	Drain-gate voltage	$R_{GS} = 20$ kΩ	-	55	V
$\pm V_{GS}$	Gate-source voltage	-	-	10	V
$I_D$	Drain current (DC)	$T_{mb} = 25$ °C	-	57	A
$I_D$	Drain current (DC)	$T_{mb} = 100$ °C	-	40	A
$I_{DM}$	Drain current (pulse peak value)	$T_{mb} = 25$ °C	-	228	A
$P_{tot}$	Total power dissipation	$T_{mb} = 25$ °C	-	125	W
$T_{stg}, T_j$	Storage & operating temperature	-	-55	175	°C

**ESD LIMITING VALUE**

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
$V_C$	Electrostatic discharge capacitor voltage	Human body model (100 pF, 1.5 kΩ)	-	2	kV

**THERMAL RESISTANCES**

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
$R_{th j-mb}$	Thermal resistance junction to mounting base	-	-	1.2	K/W
$R_{th j-a}$	Thermal resistance junction to ambient	in free air	60	-	K/W

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**STATIC CHARACTERISTICS** $T_j = 25^\circ\text{C}$  unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$V_{(\text{BR})\text{DSS}}$	Drain-source breakdown voltage	$V_{GS} = 0 \text{ V}; I_D = 0.25 \text{ mA}$	55	-	-	V
$V_{GS(\text{TO})}$	Gate threshold voltage	$T_j = -55^\circ\text{C}$ $V_{DS} = V_{GS}; I_D = 1 \text{ mA}$	50	-	-	V
$I_{DSS}$	Zero gate voltage drain current	$T_j = 175^\circ\text{C}$ $V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}$	1.0	1.5	2.0	V
$I_{GSS}$	Gate source leakage current	$T_j = -55^\circ\text{C}$ $V_{GS} = \pm 5 \text{ V}; V_{DS} = 0 \text{ V}$	0.5	-	-	V
$\pm V_{(\text{BR})\text{GSS}}$	Gate-source breakdown voltage	$T_j = 175^\circ\text{C}$ $I_G = \pm 1 \text{ mA}$	-	0.05	10	$\mu\text{A}$
$R_{DS(\text{ON})}$	Drain-source on-state resistance	$V_{GS} = 5 \text{ V}; I_D = 25 \text{ A}$ $T_j = 175^\circ\text{C}$	10	-	500	$\mu\text{A}$
			-	0.02	1	$\mu\text{A}$
			-	-	10	$\mu\text{A}$
			-	-	-	V
			-	15	18	$\text{m}\Omega$
			-	-	38	$\text{m}\Omega$

**DYNAMIC CHARACTERISTICS** $T_{mb} = 25^\circ\text{C}$  unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$g_{fs}$	Forward transconductance	$V_{DS} = 25 \text{ V}; I_D = 25 \text{ A}$	25	52	-	S
$C_{iss}$	Input capacitance	$V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}$	-	2000	2600	pF
$C_{oss}$	Output capacitance		-	390	490	pF
$C_{rss}$	Feedback capacitance		-	200	290	pF
$t_{d\text{ on}}$	Turn-on delay time	$V_{DD} = 30 \text{ V}; I_D = 25 \text{ A}; V_{GS} = 5 \text{ V}; R_G = 10 \Omega$	-	30	45	ns
$t_r$	Turn-on rise time		-	80	130	ns
$t_{d\text{ off}}$	Turn-off delay time		-	100	140	ns
$t_f$	Turn-off fall time		-	50	75	ns
$L_d$	Internal drain inductance	Measured from contact screw on tab to centre of die	-	3.5	-	nH
$L_d$	Internal drain inductance	Measured from drain lead 6 mm from package to centre of die	-	4.5	-	nH
$L_s$	Internal source inductance	Measured from source lead 6 mm from package to source bond pad	-	7.5	-	nH

**REVERSE DIODE LIMITING VALUES AND CHARACTERISTICS** $T_j = 25^\circ\text{C}$  unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$I_{DR}$	Continuous reverse drain current		-	-	57	A
$I_{DRM}$	Pulsed reverse drain current		-	-	200	A
$V_{SD}$	Diode forward voltage	$I_F = 25 \text{ A}; V_{GS} = 0 \text{ V}$ $I_F = 50 \text{ A}; V_{GS} = 0 \text{ V}$	-	0.95	1.2	V
$I_F$			-	1.0	-	V
$t_{rr}$	Reverse recovery time	$I_F = 50 \text{ A}; -dI_F/dt = 100 \text{ A}/\mu\text{s}$	-	48	-	ns
$Q_{rr}$	Reverse recovery charge	$V_{GS} = -10 \text{ V}; V_R = 30 \text{ V}$	-	0.1	-	$\mu\text{C}$

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### AVALANCHE LIMITING VALUE

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
$W_{DSS}$	Drain-source non-repetitive unclamped inductive turn-off energy	$I_D = 50 \text{ A}$ ; $V_{DD} \leq 25 \text{ V}$ ; $V_{GS} = 5 \text{ V}$ ; $R_{GS} = 50 \Omega$ ; $T_{mb} = 25 \text{ }^\circ\text{C}$	-	-	125	mJ

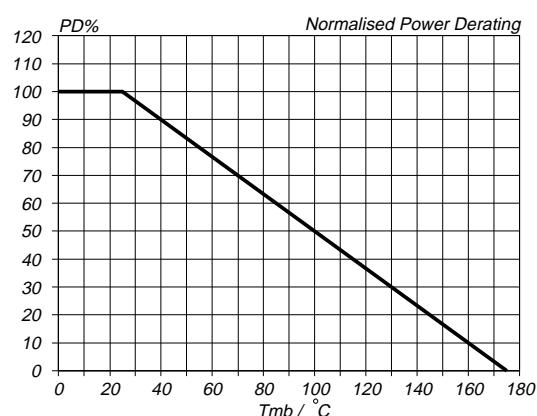


Fig. 1. Normalised power dissipation.  
 $PD\% = 100 \cdot P_D / P_{D\ 25\ }^\circ\text{C} = f(T_{mb})$

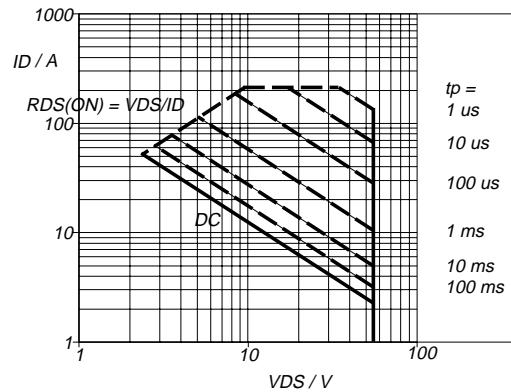


Fig. 3. Safe operating area.  $T_{mb} = 25 \text{ }^\circ\text{C}$   
 $I_D \& I_{DM} = f(V_{DS})$ ;  $I_{DM}$  single pulse; parameter  $t_p$

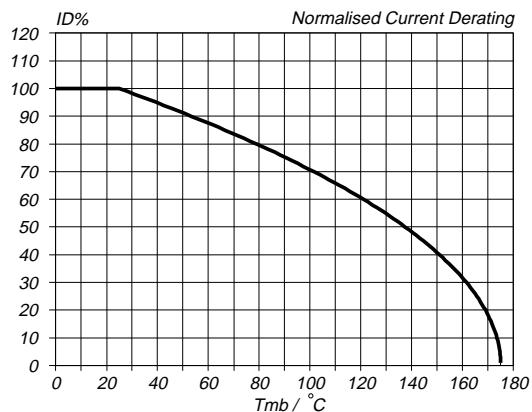


Fig. 2. Normalised continuous drain current.  
 $ID\% = 100 \cdot I_D / I_{D\ 25\ }^\circ\text{C} = f(T_{mb})$ ; conditions:  $V_{GS} \geq 5 \text{ V}$

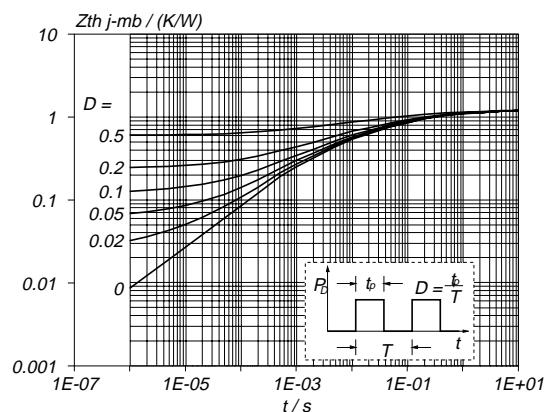


Fig. 4. Transient thermal impedance.  
 $Z_{th,j-mb} = f(t)$ ; parameter  $D = t_p/T$

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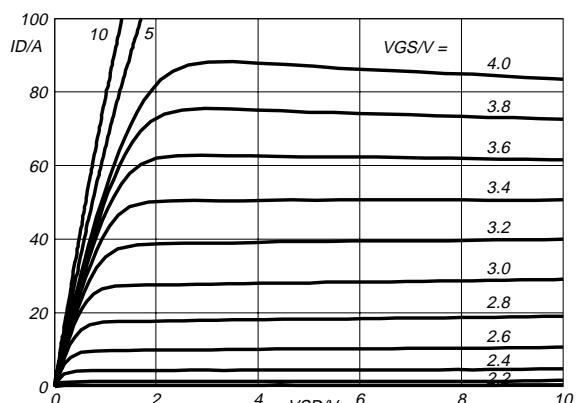


Fig.5. Typical output characteristics,  $T_j = 25^\circ\text{C}$ .  
 $I_D = f(V_{DS})$ ; parameter  $V_{GS}$

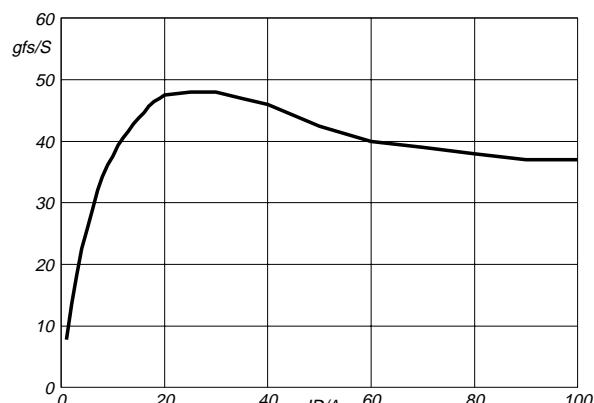


Fig.8. Typical transconductance,  $T_j = 25^\circ\text{C}$ .  
 $g_{fs} = f(I_D)$ ; conditions:  $V_{DS} = 25\text{ V}$

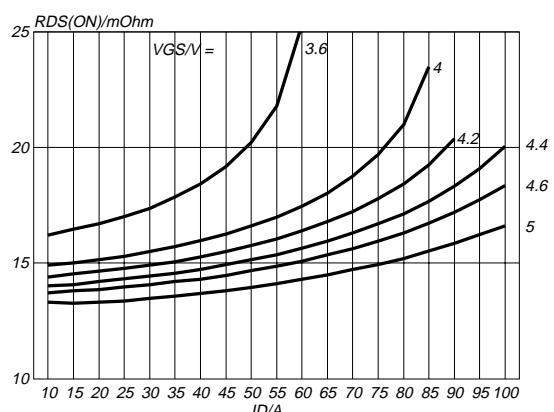


Fig.6. Typical on-state resistance,  $T_j = 25^\circ\text{C}$ .  
 $R_{DS(ON)} = f(I_D)$ ; parameter  $V_{GS}$

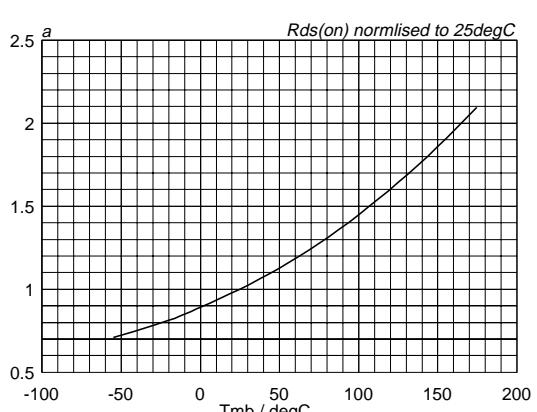


Fig.9. Normalised drain-source on-state resistance.  
 $a = R_{DS(ON)}/R_{DS(ON)25^\circ\text{C}} = f(T_m)$ ;  $I_D = 25\text{ A}$ ;  $V_{GS} = 5\text{ V}$

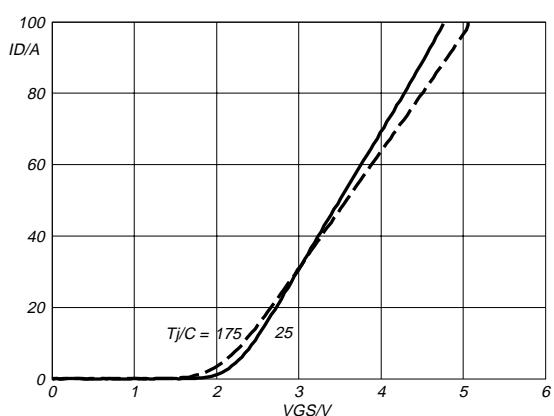


Fig.7. Typical transfer characteristics.  
 $I_D = f(V_{GS})$ ; conditions:  $V_{DS} = 25\text{ V}$ ; parameter  $T_j$

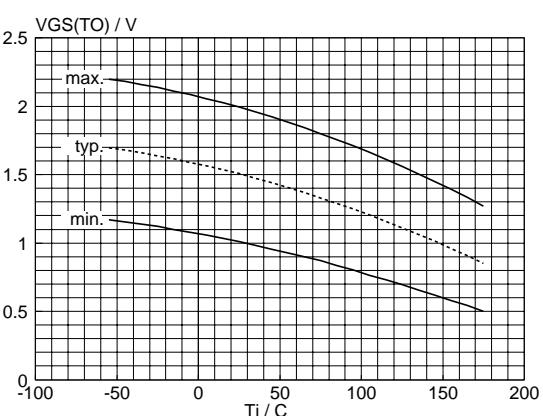
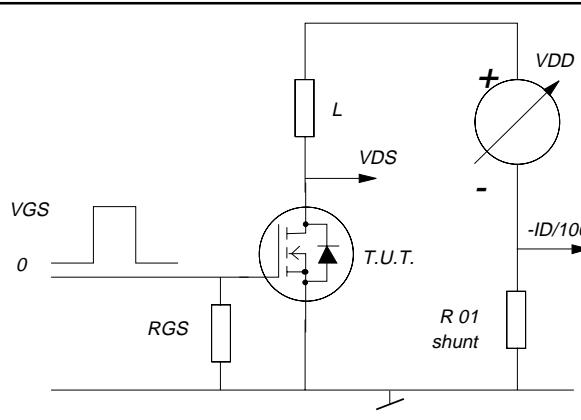
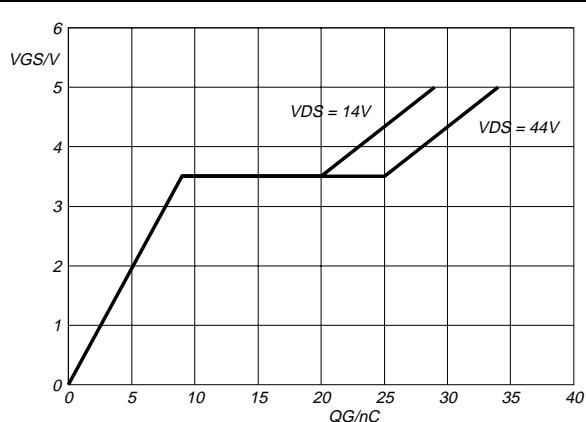
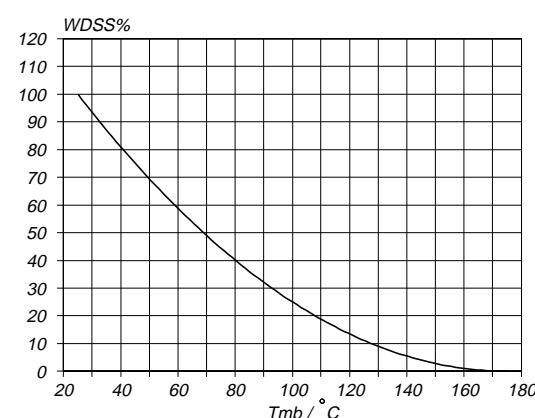
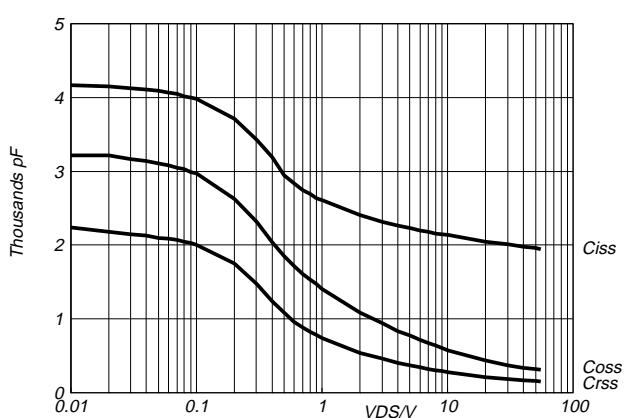
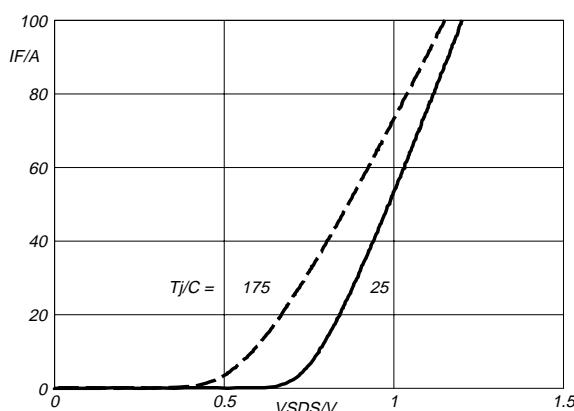
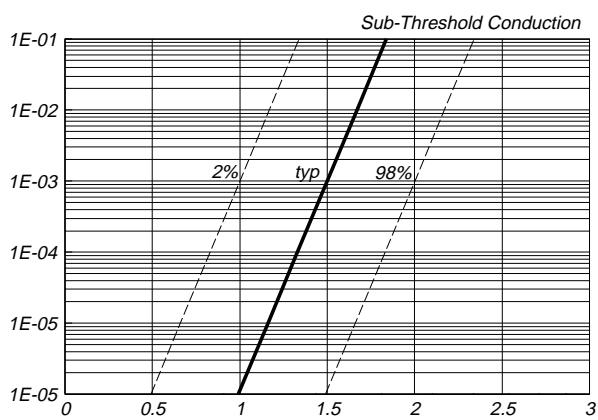


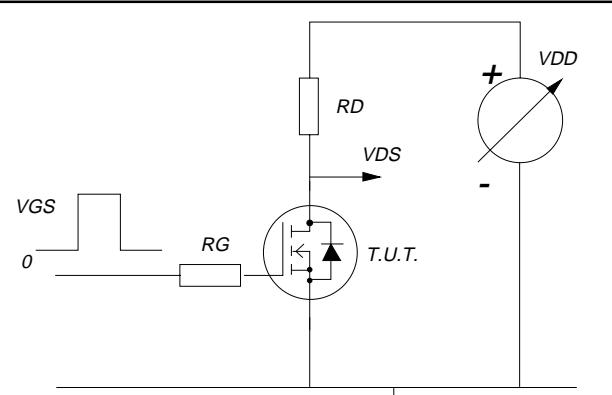
Fig.10. Gate threshold voltage.  
 $V_{GS(TO)} = f(T_j)$ ; conditions:  $I_D = 1\text{ mA}$ ;  $V_{DS} = V_{GS}$

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*Fig.17. Switching test circuit.*

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### MECHANICAL DATA

*Dimensions in mm*

Net Mass: 2 g

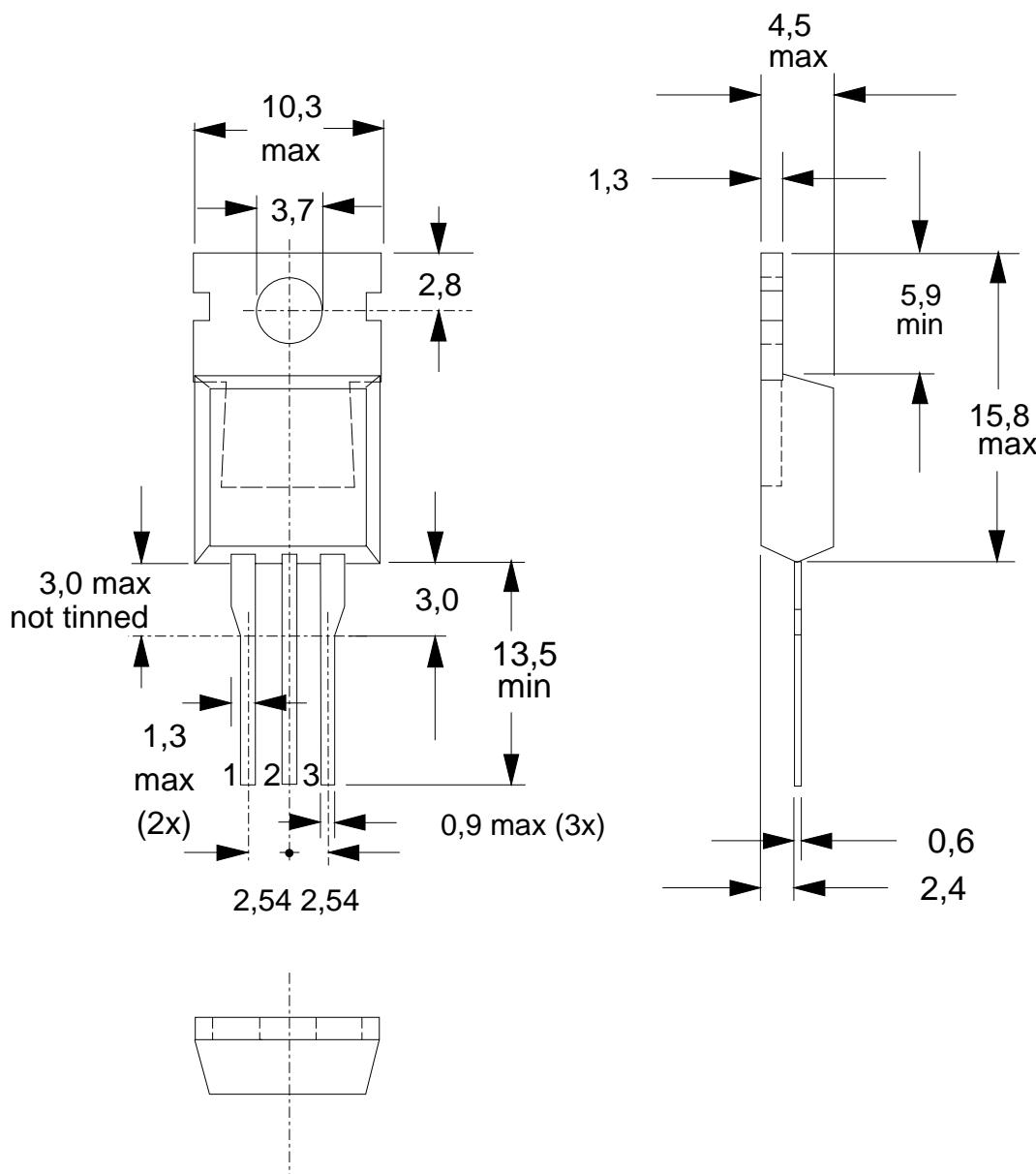


Fig.18. TO220AB; pin 2 connected to mounting base.

#### Notes

1. Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
2. Refer to mounting instructions for TO220 envelopes.
3. Epoxy meets UL94 V0 at 1/8".

**TrenchMOS™ transistor  
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<b>Data sheet status</b>	
Objective specification	This data sheet contains target or goal specifications for product development.
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.
Product specification	This data sheet contains final product specifications.
<b>Limiting values</b>	
Limiting values are given in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of this specification is not implied. Exposure to limiting values for extended periods may affect device reliability.	
<b>Application information</b>	
Where application information is given, it is advisory and does not form part of the specification.	
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